

BULK128

HIGH VOLTAGE FAST-SWITCHING NPN POWER TRANSISTOR

- STMicroelectronics PREFERRED SALESTYPE
- NPN TRANSISTOR
- HIGH VOLTAGE CAPABILITY
- LOW SPREAD OF DYNAMIC PARAMETERS
- MINIMUM LOT-TO-LOT SPREAD FOR RELIABLE OPERATION
- VERY HIGH SWITCHING SPEED

APPLICATIONS:

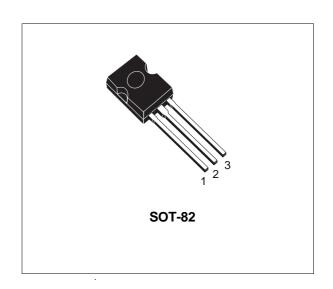
 ELECTRONIC BALLASTS FOR FLUORESCENT LIGHTING

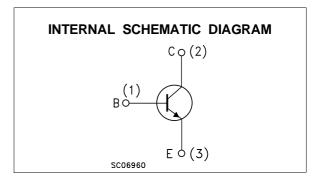
DESCRIPTION

The device is manufactured using high voltage Multi Epitaxial Planar technology for high switching speeds and medium voltage capability.

It uses a Cellular Emitter structure with planar edge termination to enhance switching speeds while maintaining the wide RBSOA.

The device is designed for use in lighting applications and low cost switch-mode power supplies.





ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
V _{CES}	Collector-Emitter Voltage (V _{BE} = 0)	700	V
V_{CEO}	Collector-Emitter Voltage (I _B = 0)	400	V
V _{EBO}	Emitter-Base Voltage ($I_C = 0$, $I_B = 2$ A, $t_p < 10\mu s$, $T_j < 150$ °C)	V _{(BR)EBO}	V
Ic	Collector Current	4	Α
I _{CM}	Collector Peak Current (t _p < 5 ms)	8	Α
I _B	Base Current	2	А
I_{BM}	Base Peak Current (t _p < 5 ms)	4	Α
Ptot	Total Dissipation at T _c = 25 °C	55	W
T _{stg}	Storage Temperature	-65 to 150	°C
T_j	Max. Operating Junction Temperature	150	°C

November 2001 1/7

THERMAL DATA

R _{thj-case}	Thermal Resistance Junction-Case	Max	2.27	°C/W
$R_{thj-amb}$	Thermal Resistance Junction-Ambient	Max	80	°C/W

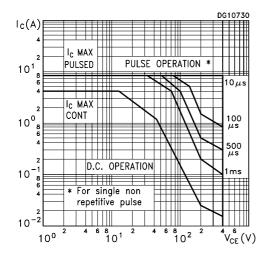
ELECTRICAL CHARACTERISTICS (T_{case} = 25 °C unless otherwise specified)

Symbol	Parameter	Test Conditions		Min.	Тур.	Max.	Unit
I _{CES}	Collector Cut-off Current (V _{BE} = -1.5 V)	V _{CE} = 700 V V _{CE} = 700 V	T _C = 125 °C			50 500	μA μA
V _{(BR)EBO}	Emitter-Base Breakdown Voltage (I _C = 0)	I _E = 10 mA		9		18	V
V _{CEO(sus)} *	Collector-Emitter Sustaining Voltage (I _B = 0)	I _C = 100 mA	L = 25 mH	400			V
I _{CEO}	Collector Cut-Off Current (I _B = 0)	V _{CE} = 400 V				250	μΑ
V _{CE(sat)} *	Collector-Emitter Saturation Voltage	I _C = 0.5 A I _C = 1 A I _C = 2.5 A I _C = 4 A	$I_B = 0.1 A$ $I_B = 0.2 A$ $I_B = 0.5 A$ $I_B = 1 A$		0.5	0.7 1 1.5	V V V
V _{BE(sat)} *	Base-Emitter Saturation Voltage	I _C = 0.5 A I _C = 1 A I _C = 2.5 A	$I_B = 0.1 A$ $I_B = 0.2 A$ $I_B = 0.5 A$			1.1 1.2 1.3	V V V
h _{FE} *	DC Current Gain	I _C = 10 mA I _C = 2 A	V _{CE} = 5 V V _{CE} = 5 V	10 14		28	
t _s	RESISTIVE LOAD Storage Time Fall Time	$V_{CC} = 125 \text{ V}$ $I_{B1} = 0.4 \text{ A}$ $T_p = 30 \mu\text{s}$	$I_C = 2 A$ $I_{B2} = -0.4 A$ (see fig.2)	1.5	0.2	3 0.4	μs μs
t _s	INDUCTIVE LOAD Storage Time Fall Time	I _C = 2 A V _{BE(off)} = -5 V V _{clamp} = 200 V	$I_{B1} = 0.4 A$ $R_{BB} = 0 \Omega$ (see fig.1)		0.6 0.1	1 0.2	μs μs

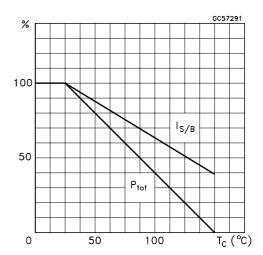
^{*} Pulsed: Pulse duration = 300 μs, duty cycle 1.5 %.

2/7

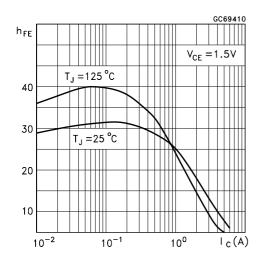
Safe Operating Areas



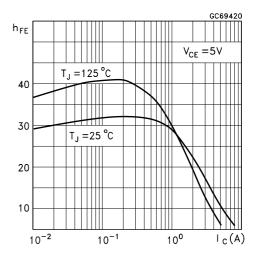
Derating Curve



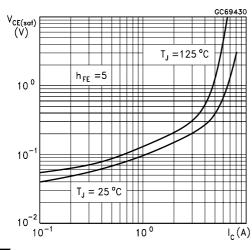
DC Current Gain



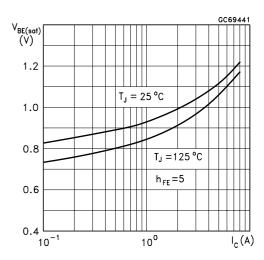
DC Current Gain



Collector Emitter Saturation Voltage

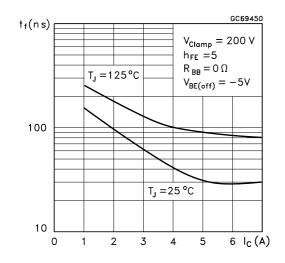


Base Emitter Saturation Voltage

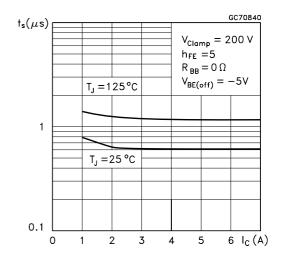


477

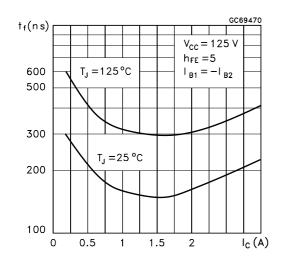
Inductive Load Fall Time



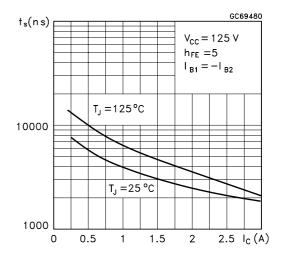
Inductive Load Storage Time



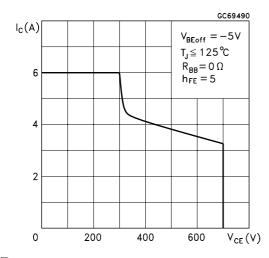
Resistive Load Fall Time



Resistive Load Storage Time



Reverse Biased SOA



4/7

Figure 1: Inductive Load Switching Test Circuit.

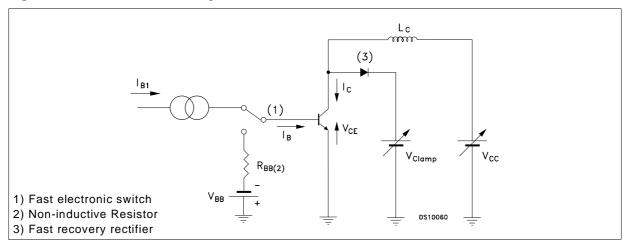
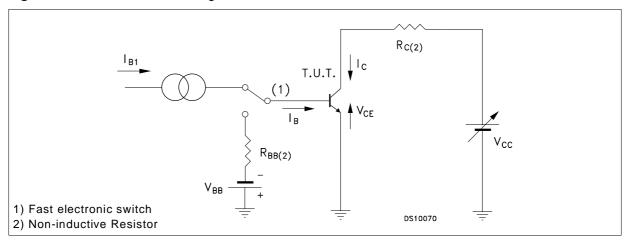
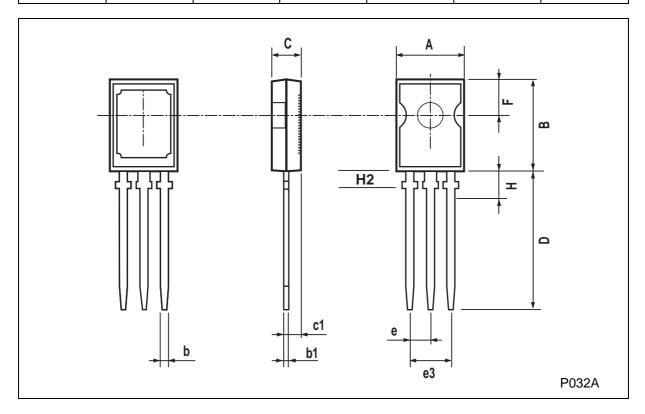


Figure 2: Resistive Load Switching Test Circuit.



SOT-82 MECHANICAL DATA

DIM.	mm			inch			
51141.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.	
А	7.4		7.8	0.291		0.307	
В	10.5		10.8	0.413		0.444	
b	0.7		0.9	0.028		0.035	
b1	0.49		0.75	0.019		0.030	
С	2.4		2.7	0.04		0.106	
c1	1.0		1.3	0.039		0.05	
D	15.4		16	0.606		0.629	
е		2.2			0.087		
e3	4.15		4.65	0.163		0.183	
F		3.8			0.150		
Н			2.54		0.100		
H2		2.15			0.084		



6/7

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